TOSHIBA PHOTOCOUPLER IRED & PHOTO-IC

TLP117

PDP (Plasma Display Panel) FA (Factory Automation) High-Speed Interface

The Toshiba TLP117 consists of an infrared emitting diode and an integrated high-gain, high-speed photodetector.

Inverter logic (totempole output)

Package type : MFSOP6

Guaranteed performance over temperature : -40 to 105°C

Power supply voltage : 4.5 to 5.5 V

Input thresholds current : I_{FHL}=5 mA (max)

Propagation delay time (tpHL/tpLH): 30 ns (max) at VL=0 V

: 20 ns (max) at VL=1.1 V

Switching speed : 50 MBd (typ.)

Common mode transient immunity : 10 kV/μs (min)

Isolation voltage : 3750 Vrms

UL-recognized : UL 1577, File No.E67349

cUL-recognized : CSA Component Acceptance Service No.5A File No.E67349

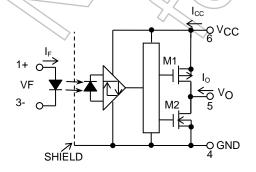
VDE-approved : EN 60747-5-5 (Note 1)

Note 1: When a VDE approved type is needed, please designate the Option(V4).

Truth Table

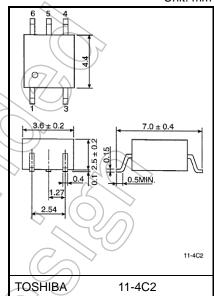
Input	LED	M1	M2	Output
Н	ON	OFF	ØN	L <
L	OFF	ON	OFF	Н

Schematic



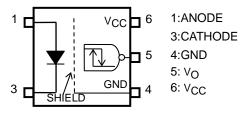
 $0.1 \mu F$ bypass capacitor must be connected between pins 6 and 4

Unit: mm



Weight: 0.09 g (typ.)

Pin Configuration (Top View)



Start of commercial production 2007-05

Absolute Maximum Ratings (Ta=25°C)

	Characteristic	Symbol	Rating	Unit	
	Forward current	ΙF	25	mA	
	Forward current derating (Ta≥85°C)	ΔΙΕ/ΔΤα	-0.7	mA/°C	
ED	Peak transient forward current (Note 1)	I _{FPT} 1		A	
쁘	Reverse voltage	V _R 6		(V)	
	Diode power dissipation	PD	40	mW	
	Diode power dissipation derating (Ta≥85°C)	ΔΡ _D /ΔΤα	-1.0	mW/°C	
~	Output current	lo (10)	mA	
DETECTOR	Output voltage	νo	6	V	
DETE	Supply voltage	VCC	> 6	y	
	Output power dissipation	(Po)	40 🔷	mW)	
Oper	ating temperature range	Topr	-40 to 105	\°C\	
Stora	ge temperature range	T _{stg}	-55 to 125	Ç	
Lead	solder temperature(10 s)	T _{sol}	260	√°C	
Isola	tion voltage (AC,60 s, R.H. ≤ 60 %,) (Note 2)	BVs	3750	Vrms	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Pulse width PW≤1 μs, 300 pps.

Note 2: This device is regarded as a two-terminal device; pins 1 and 3 are shorted together, and pins 4,5 and 6 are shorted together.

Recommended Operating Conditions

Characteristi	С	Symbol	Min	Тур.	Max	Unit
Input current, ON	. 6	IF(ON)	10	_	16	mA
Input voltage , OFF		VF(OFF)	0	_	1.0	V
Supply voltage(*)	(Note 1)	Vcc	4.5	5.0	5.5	٧

^{*} This item denotes operating ranges, not meaning of recommended operating conditions.

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device.

Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

Note 1: The detector of this product requires a power supply voltage (V_{CC}) of 4.5 V or higher for stable operation. If V_{CC} is lower than this value, I_{CC} may increase or the output may be unstable.

Be sure to use the product after checking the supply current, and the operation of a power-on/-off.



Electrical Characteristics

(Unless otherwise specified, Ta=-40 to 105°C, VCC =4.5 to 5.5V)

Characteristic		Symbol	Test Circuit	Conditions	Min	Тур.	Max	Unit
Input forward voltage		VF	_	IF = 10 mA, Ta = 25 °C	1.45	1.6	1.85	V
Temperature coefficient of forward voltage		ΔV _F /ΔΤα	_	I _F = 10 mA		-2.0	_	mV/°C
Input reverse current		IR	1	V _R = 5 V, Ta = 25 °C		<u>)</u>	10	μА
Capacitance between Input terminals		Ст	_	V _F = 0 V, f = 1 MHz, Ta = 25 °C		60	_	pF
	"L" Level	V _{OL}	1	I _{OL} = 4 mA, I _F = 10 mA)_	_	0.6	V
Output voltage	"H" Level	Vон	2	$I_{OH} = -4mA$, $V_{CC} = 4.5V$ $V_{F} = 1.05V$ $V_{CC} = 5.5V$	3.9 4.9	<u> </u>		٧
Supply ourront	"L" Level	Iccl	3	I _F = 10 mA		2	5.0	mA
Supply current	"H" Level	Іссн	4	V _F = 0 V			5.0	mA
Input current	Output : H → L	I _{FHL}		I _O = 20 μA, V _O < 0.3 V			5	mA
Input voltage	Output : L → H	V _{FL} H	=	1 _O = -20 μA, V _O > 4.0 V	0.8			V

^{*}All typical values are at Ta = 25 °C unless otherwise specified.

Isolation Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Conditions	Min	Тур.	Max	Unit
Capacitance input to output	Cs	Vs = 0 V, f = 1 MHz	_	0.8	1	pF
Isolation resistance	Rs	R.H. ≤ 60 %, Vs = 500 V	1×10 ¹²	10 ¹⁴	_	Ω
Isolation voltage	BVs	AC, 60 s	3750	-	-	V _{rms}

Note: This device is regarded as a two-terminal device: pins 1 and 3 are shorted together, and pins 4,5 and 6 are shorted together.

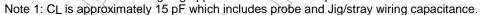
Switching Characteristics

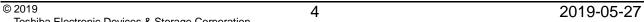
(Unless otherwise specified, Ta=-40 to 105°C, VCC=4.5 to 5.5V)

Characteristic	Symbol	Test Circuit	Conditions	Min	Тур.	Max	Unit	
Propagation delay time to logic high →Low output	t _{pHL}		V _{IN} = 0 → 5 V		_	_	30	ns
Propagation delay time to logic low → High output	tрLН	_	$V_{IN} = 5 \rightarrow 0 V$ $R_{IN} = 360 \Omega$ $C_{IN} = 22 pF$			_	30	ns
Switching time dispersion between ON and OFF	tpHL=tpLH	5	V _L = 0 V (Note 1)		77/0	<i>)</i>	10	ns
Output fall time (90-10%)	tf		$V_{IN} = 0 \rightarrow 5 V$		(-))	3		ns
Output rise time (10-90%)	tr		$V_{IN} = 5 \rightarrow 0 V$		\sim	2	_	ns
Propagation delay time to logic high → Low output	t _{pHL}		V _{IN} = 1.1 → 5 V		/ _	_	20	ns
Propagation delay time to logic low → High output	tрLН		V _{IN} =5 → 1.1 V	>	_	2	20	ns
Propagation delay skew	T _{psk}		- Rin = 360 Ω $-$ Cin = 22 pF	4	> _ (() <u>)</u>	16	ns
Switching time dispersion between ON and OFF	tpHL=tpLH	6	VL = 1.1 V (Note 1)		7	2	8	ns
Output fall time (90-10%)	t _f		V _{IN} = 1.1 → 5 V			3	_	ns
Output rise time (10-90%)	t _r		$V_{IN}=5 \rightarrow 1.1V$		<u> </u>	3	_	ns
Data rate	Т				/	50	_	MBd
Common mode transient immunity at high Level output	СМн		$V_{CM} = 1000 \text{ V}_{p-p}, \text{ Ta} = 25 \text{ °C}$ $I_F = 0 \text{ mA}, \text{ V}_{CC} = 5 \text{ V}, \text{ V}_{O}(\text{Min}) = 4$	V,	10000	_	_	V/μs
Common mode transient immunity at low level output	CML		V _{CM} = 1000 V _P -p, Ta = 25 °C I _F = 10 mA, V _{CC} = 5 V, V _O (Max)= 0	0.4 V	-10000	_	_	V/μs

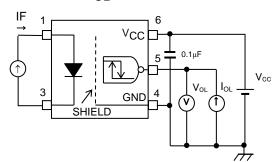
^{*}All typical values are at Ta = 25 °C, Vcc = 5 V.

Note: This product has an automatic threshold control (ATC) circuit in order to reduce input current dependence of its switching time. The ATC circuit may not be able to respond accordingly when an input signal is driven after a prolonged absence of signals to the product. As a result, switching operation, pertaining to the first pulse of an input signal, could be unstable. Theoretically however, stable switching operation should be achievable from the second pulse onwards. As such, please check the switching operation and take the appropriate measures when designing applications in which this product shall be used.

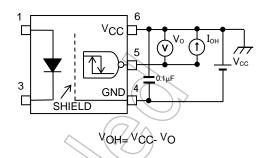




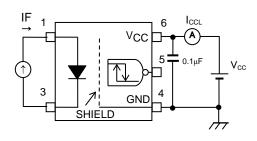




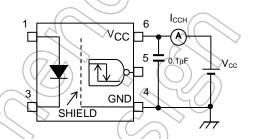
TEST CIRCUIT 2: VOH



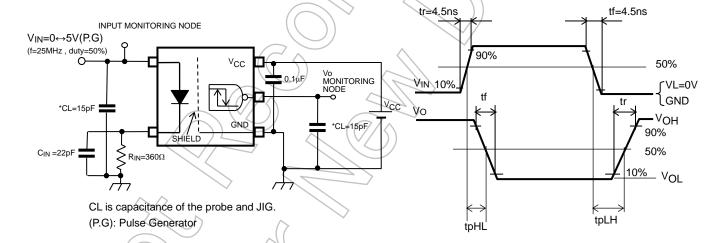
TEST CIRCUIT 3: ICCL



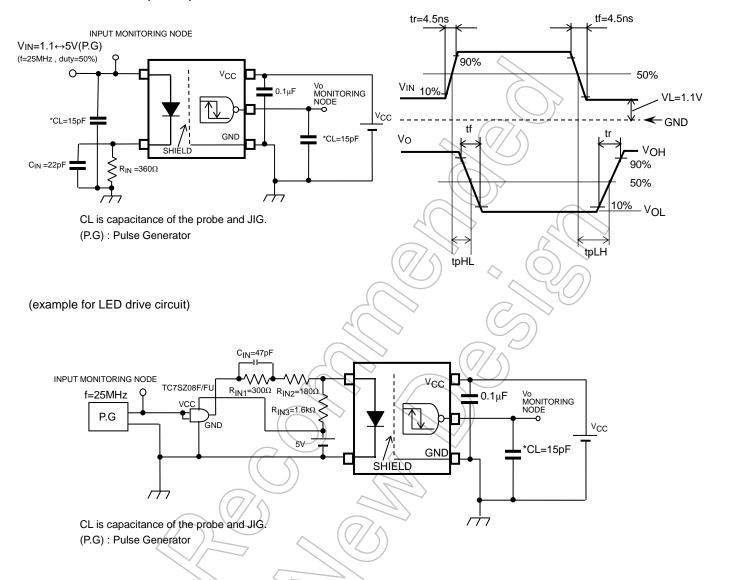
TEST CIRCUIT 4: ICCH



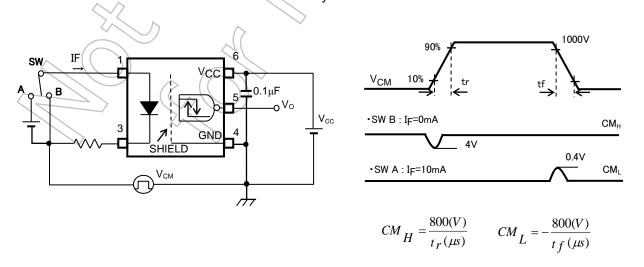
TEST CIRCUIT 5: tpHL, tpLH



TEST CIRCUIT 6: tpHL, tpLH



TEST CIRCUIT 7: Common-Mode Transient Immunity Test Circuit



RESTRICTIONS ON PRODUCT USE

Toshiba Corporation and its subsidiaries and affiliates are collectively referred to as "TOSHIBA". Hardware, software and systems described in this document are collectively referred to as "Product".

- TOSHIBA reserves the right to make changes to the information in this document and related Product without notice.
- This document and any information herein may not be reproduced without prior written permission from TOSHIBA. Even with TOSHIBA's written permission, reproduction is permissible only if reproduction is without alteration/omission.
- Though TOSHIBA works continually to improve Product's quality and reliability, Product can malfunction or fail. Customers are responsible for complying with safety standards and for providing adequate designs and safeguards for their hardware, software and systems which minimize risk and avoid situations in which a malfunction or failure of Product could cause loss of human life, bodily injury or damage to property, including data loss or corruption. Before customers use the Product, create designs including the Product, or incorporate the Product into their own applications, customers must also refer to and comply with (a) the latest versions of all relevant TOSHIBA information, including without limitation, this document, the specifications, the data sheets and application notes for Product and the precautions and conditions set forth in the "TOSHIBA Semiconductor Reliability Handbook" and (b) the instructions for the application with which the Product will be used with or for. Customers are solely responsible for all aspects of their own product design or applications, including but not limited to (a) determining the appropriateness of the use of this Product in such design or applications; (b) evaluating and determining the applicability of any information contained in this document, or in charts, diagrams, programs, algorithms, sample application circuits, or any other referenced documents; and (c) validating all operating parameters for such designs and applications. TOSHIBA ASSUMES NO LIABILITY FOR CUSTOMERS' PRODUCT DESIGN OR APPLICATIONS.
- PRODUCT IS NEITHER INTENDED NOR WARRANTED FOR USE IN EQUIPMENTS OR SYSTEMS THAT REQUIRE
 EXTRAORDINARILY HIGH LEVELS OF QUALITY AND/OR RELIABILITY, AND/OR A MALFUNCTION OR FAILURE OF WHICH
 MAY CAUSE LOSS OF HUMAN LIFE, BODILY INJURY, SERIOUS PROPERTY DAMAGE AND/OR SERIOUS PUBLIC IMPACT
 ("UNINTENDED USE"). Except for specific applications as expressly stated in this document, Unintended Use includes, without
 limitation, equipment used in nuclear facilities, equipment used in the aerospace industry, lifesaving and/or life supporting medical
 equipment, equipment used for automobiles, trains, ships and other transportation, traffic signaling equipment, equipment used to
 control combustions or explosions, safety devices, elevators and escalators, and devices related to power plant. IF YOU USE
 PRODUCT FOR UNINTENDED USE, TOSHIBA ASSUMES NO LIABILITY FOR PRODUCT. For details, please contact your
 TOSHIBA sales representative or contact us via our website.
- · Do not disassemble, analyze, reverse-engineer, alter, modify, translate or copy Product, whether in whole or in part.
- Product shall not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any
 applicable laws or regulations.
- The information contained herein is presented only as guidance for Product use. No responsibility is assumed by TOSHIBA for any infringement of patents or any other intellectual property rights of third parties that may result from the use of Product. No license to any intellectual property right is granted by this document, whether express or implied, by estoppel or otherwise.
- ABSENT A WRITTEN SIGNED AGREEMENT, EXCEPT AS PROVIDED IN THE RELEVANT TERMS AND CONDITIONS OF SALE
 FOR PRODUCT, AND TO THE MAXIMUM EXTENT ALLOWABLE BY LAW, TOSHIBA (1) ASSUMES NO LIABILITY
 WHATSOEVER, INCLUDING WITHOUT LIMITATION, INDIRECT, CONSEQUENTIAL, SPECIAL, OR INCIDENTAL DAMAGES OR
 LOSS, INCLUDING WITHOUT LIMITATION, LOSS OF PROFITS, LOSS OF OPPORTUNITIES, BUSINESS INTERRUPTION AND
 LOSS OF DATA, AND (2) DISCLAIMS ANY AND ALL EXPRESS OR IMPLIED WARRANTIES AND CONDITIONS RELATED TO
 SALE, USE OF PRODUCT, OR INFORMATION, INCLUDING WARRANTIES OR CONDITIONS OF MERCHANTABILITY, FITNESS
 FOR A PARTICULAR PURPOSE, ACCURACY OF INFORMATION, OR NONINFRINGEMENT.
- GaAs (Gallium Arsenide) is used in Product. GaAs is harmful to humans if consumed or absorbed, whether in the form of dust or vapor. Handle with care and do not break, cut, crush, grind, dissolve chemically or otherwise expose GaAs in Product.
- Do not use or otherwise make available Product or related software or technology for any military purposes, including without limitation, for the design, development, use, stockpiling or manufacturing of nuclear, chemical, or biological weapons or missile technology products (mass destruction weapons). Product and related software and technology may be controlled under the applicable export laws and regulations including, without limitation, the Japanese Foreign Exchange and Foreign Trade Law and the U.S. Export Administration Regulations. Export and re-export of Product or related software or technology are strictly prohibited except in compliance with all applicable export laws and regulations.
- Please contact your TOSHIBA sales representative for details as to environmental matters such as the RoHS compatibility of
 Product. Please use Product in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled
 substances, including without limitation, the EU RoHS Directive. TOSHIBA ASSUMES NO LIABILITY FOR DAMAGES OR LOSSES
 OCCURRING AS A RESULT OF NONCOMPLIANCE WITH APPLICABLE LAWS AND REGULATIONS.

TOSHIBA ELECTRONIC DEVICES & STORAGE CORPORATION

https://toshiba.semicon-storage.com/

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for High Speed Optocouplers category:

Click to view products by Toshiba manufacturer:

Other Similar products are found below:

HCPL-2201-300 TLP558(F) JAN4N24 610737H HCPL2630M HCPL2731SM HCPL2630SM PS9817A-1-F3-AX TLP2766A(E EL816S2(C)(TU)-F TLP281-4 PS9121-F3-AX PS9123-F3-AX HCPL2531S HCPL2631SD HCPL-4661-500E TLP118(TPL,E) TLP521-2XGB TLP621-2XGB 4N46-300E JANTXV4N24U SFH6318T 6N135-300E TIL198 TLP2309(TPL,E) TLP2355(TPL,E TLP521-4GR TLP521-4XGB TLP621-4X TLP621XSM IS281-4GB IS181GR ICPL2631 ICPL2630 ICPL2601 TLP714(F) TLP754(F) FOD260LSDV ACPL-M21L-500E ACPL-064L-500E PS2501-1XSM PS2505-1 PS2561L2-1-F3-A PS2913-1-F3-AX PS9821-2-F3-AX FOD0721R2 FODM8061R2V 6N135SDM 6N137SDM 6N138-000E